

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10571866	VEELAERT ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	YUN QIAN	4162

### **SEARCHED**

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
	EAST search in PG-pub, PAT, Dewent, EPO and JPO; 536/128 text and 127/65, 67, 71 text.	7/7/2008	yq
	Consult with Curtis Mayes	7/8/2008	yq

### **SEARCH NOTES**

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>

### **INTERFERENCE SEARCH**

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>